


<b>Search Notes</b> 	<b>Application/Control No.</b> 10590872	<b>Applicant(s)/Patent Under Reexamination</b> TAKAI ET AL.
	<b>Examiner</b> EVAN DZIERZYNSKI	<b>Art Unit</b> 2875

SEARCHED			
Class	Subclass	Date	Examiner
362	97.1, 629	6/2/2011	ed

SEARCH NOTES		
Search Notes	Date	Examiner
EAST word and inventor search attached	6/2/2011	ed

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--